ELECTRONIC INFORMATION DISCLOSURE STATEMENT

Electronic Version v18

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Title of Invention

METHOD OF ASSESSING POTENTIAL FOR CHARGING DAMAGE IN SOI DESIGNS AND STRUCTURES FOR ELIMINATING POTENTIAL FOR DAMAGE

Application Number :

Confirmation Number:

First Named Applicant: Henry Bonges
Attorney Docket Number: BUR920030084US1

Art Unit: Examiner:

Search string: (5994742 or 5998299 or 6194233 or 6235642 or 6292927 or 6016062 or 6414358

or 6441397 or 6448599 or 6566716 or 6417544 or 20010028056 or 20010045667 or 20010046718 or 20020000579 or 20020031617 or 20020037651 or 20020063298

or 20020158348 or 20030027399 or 20030068878 or 20030075762 or

20030114015 or 20020142526).pn

US Patent Documents

Note: Applicant is not required to submit a paper copy of cited US Patent Documents

init	Cite.No.	Patent No.	Date	Patentee	Kind	Class	Subclass
	1	5994742	1999-11-30	Krishnan et al.			
	2	5998299	1999-12-07	Krishnan			
	3	6194233	2001-02-27	Bedner et al.			
	4	6235642	2001-05-22	Lee et al.			
	5	6292927	2001-09-18	Gopisetty et al.			
	6	6016062	2000-01-18	Nicollian et al.			
	7	6414358	2002-07-02	Lin et al.			
	8	6441397	2002-08-27	Yamamoto			
	9	6448599	2002-09-10	Wang			
	10	6566716	2003-05-20	Lin et al.			
	11	6417544	2002-07-09	Jun et al.			

US Published Applications

Note: Applicant is not required to submit a paper copy of cited US Published Applications

init	Cite.No.	Pub. No.	Date	Applicant	Kind	Class	Subclass
	1	20010028056	2001-10-11	Yamamoto			
	2	20010045667	2001-11-29	Yamamuchi et			

	ı			I	I	
			al.			
3	20010046718	2001-11-29	Iranmanesh			
4	20020000579	2002-01-03	Aoyama			
5	20020031617	2002-03-14	Sumiya et al.			
6	20020037651	2002-03-28	Lee			
7	20020063298	2002-05-30	Wang			
8	20020158348	2002-10-31	Petrucci et al.			
9	20030027399	2003-02-06	Iranmanesh			
10	20030068878	2003-04-10	Lin et al.			
11	20030075762	2003-04-24	Lin et al.			
12	20030114015	2003-06-19	Tokashiki			
13	20020142526	2002-10-03	Khare et al.			

Signature

Examiner Name	Date		